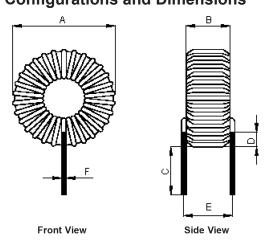
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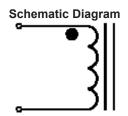


Configurations and Dimensions



Α	16mm (Max.)
В	8.5mm (Max.)
С	15 ±2mm
D	1mm (Max.)
Е	6.5 ±2mm
F	Ø0.8 ±0.1mm

RoHS Compliant



Note:

- 1. Wire UEFN/U (155°C) Ø0.8mm
- 2. 24TS (Reference) C.W

Test Data for Mechanical

Test Item	A mm	B mm	C mm	D mm	E mm	F mm
Specification	16 (Max.)	8.5 (Max.)	15 ±2	1 (Min.)	6.5 ±2	Ø0.3 (Ref.)
1	14.96	6.71	14.99	1.13	6.11	0.79
2	15.16	6.77	14.81	1.22	5.81	0.78
3	15.19	6.86	14.54	1.19	5.73	0.77
4	15.2	6.88	14.52	1.27	5.84	0.81
5	15.02	6.73	14.63	1.66	6.32	0.8
Average	15.11	6.79	14.7	1.29	5.96	0.79

Material List

No.	Item	Material Description
1	Core	T50-75-TAF200 (Red / White)
2	Wire	Ø0.8mm UEFN/U (155°C)
3	Solder (Lead-free)	Sn99.3% / Cu0.7%

Electrical Characteristics

Test Condition		
10kHz / 5mA	L	20μH ±20%
T _A = 25°C	DCR	20mΩ (Max.)
10kHz / 5mA Irms = 3A	ΔΤ	Temperature rise 40°C (Max.)

Operating temperature : -55°C to +130°C

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Reliability Test

Test Item	Specifications		Test Method and Remarks	
Operating temperature range	-55°C to +130°C		Including temperature r	rise due to self-generated heat.
Storage condition	Ambient temperature Humidity	: 0°C to 40°C : Below 70% RH	To maintain the solderability of terminal electrodes, care must be taken to control temperature and humidity in the storage area.	
Moisture sensitivity	Appearance DCR change Inductance change	: No abnormality No damage : Within ±5% : Within ±5%	According to J-STD-02 Test condition Test duration Recovery	0B level 3 : 60°C 60% RH : 40 hrs : 1 to 2 hours of recovery under the standard condition after the removal from the test chamber.
Solderability	All termination shall exhibit a continuous solder coating free from defects for a minimum of 95% of the surface area of any individual lead.		According to J-STD-00 Steam aging category Steam aging duration Solder Solder temperature Dip time	2B : 97°C 98% RH : 8 hrs : Lead-free solder : 260 ±5°C : 5 +0 / -0.5s

Test Data for Electrical

Test Item	L µH	DCR mΩ	ΔΤ
Condition	10kHz / 5mA	T _A = 25°C	10kHz / 5mA Irms = 3A
Specification	20 ±20%	20 (Max.)	Temperature rise 40°C (Max.)
1	20.53	16.38	
2	20.76	16.82	
3	21.17	16.9	OK
4	18.98	16.08	
5	20.57	16.95	
Average	20.4	16.63	OK

Part Number Table

	Description	Part Number
Ī	Inductor, 20µH, 20%, 2 Pins	MCAP105020023A-200MU

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